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Application/Control No.	Applicant(s)/Patent under Reexamination
10/667,824	CHENEY ET AL.
Examiner	Art Unit
Lakehmi S. Channavaijala	1615

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Class	Subclass	Date	Examiner
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west- all data bases -text and inventor name; stn-caplus- attached	1/4/2007	LC
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